

**Notice of References Cited**

Application/Control No.

10/565,530

Applicant(s)/Patent Under  
Reexamination  
KAWABATA ET AL.

Examiner

CARINA YUN

Art Unit

2193

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,070,011	05-2000	Liu et al.	717/160
*	B	US-2004/0098713	05-2004	Ogawa et al.	717/160
*	C	US-6,148,439	11-2000	Nishiyama, Hiroyasu	717/160
*	D	US-5,704,053	12-1997	Santhanam, Vatsa	717/158
*	E	US-6,038,398	03-2000	Schooler, Richard	717/160
*	F	US-2004/0015917 A1	01-2004	Click et al.	717/150
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.